

### **Considerations for GPU SEE Testing**

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# **Acronyms**

Acronym	Definition
DUT	Device Under Test
GPU	Graphics Processing Unit
MBU	Multi-Bit Upset
NEPP	NASA Electronic Parts and Packaging
PTX	Parallel Thread Execution
RTOS	Real-time Operating System
SBU	Single-Bit Upset
SEE	Single Event Effect
SEFI	Single Event Functional Interrupt
SEU	Single Event Upset
SIMD	Single Instruction Multiple Data
SoC	System on Chip



#### **Outline**

- GPU technology
- The setup around the test setup
- Parameter considerations
- Lessons learned



### **Technology**

- Graphics Processing Units (GPU) & General Purpose Graphics Processing Units (GPGPU)
  - Are considered a compute device or coprocessor
  - Is not a standalone multiprocessor
- Using high-level languages, GPU-accelerated applications run the sequential part of their workload on the CPU – which is optimized for single-threaded performance – while accelerating parallel processing on the GPU.



### **Purpose**

- GPUs are best used for single instructionmultiple data (SIMD) parallelism
  - Perfect for breaking apart a large data set into smaller pieces and processing those pieces in parallel
- Key computation pieces of mission applications can be computed using this technique
  - Sensor and science instrument input
  - Object tracking and obstacle identification
  - Algorithm convergence (neural network)
  - Image processing
  - Data compression algorithms



#### **Device Selection**

 Unfortunately, GPUs come in multiple types, acting as primary processor (SoC) and coprocessor (GPU)







**Smart Phones** 



**Intel Skylake Processor** 





#### **Device Software**

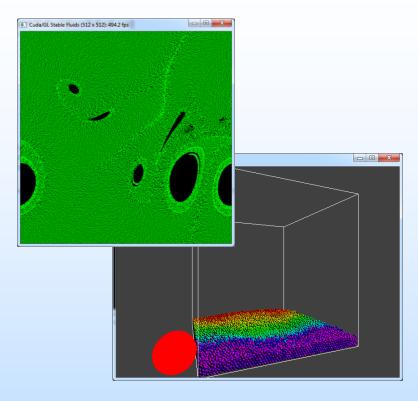
- Does it need its own operating system?
  - E.g. Linux, Android, RTOS
- Can we just push code at it?
  - E.g. Assembly, PTX, C
- Payload normalization
  - Can we run the same code on the previous generation and next generation of the device?
  - Cannot with CUDA code; can with OpenCL

Real-time Operating System (RTOS)
Parallel Thread Execution (PTX)
CUDA is a parallel computing platform and application programming interface model created by Nvidia



### **Payloads**

- Visual Simulations
  - Sample code
  - Fuzzy Donut (i.e. Furmark)
- Sensor streams
  - Camera feed
  - Offline video feed
- Computational loading
  - Scientific computing models
- Easy Math
  - -0+0... wait ... should = 0





### **Test Setup**

- Things to consider in the test environment
  - Operating system daemons
  - Location of payload and results
  - Data paths upstream/downstream
  - Control of electrical sources
  - Temperature control (i.e. heaters) in a vacuum
- Things to consider in the device under test (DUT)
  - Is the die accessible?
  - What functional blocks are accessible?
  - Which functions are independent of each other?
  - Does it have proprietary or open software?



#### **Test Environment**

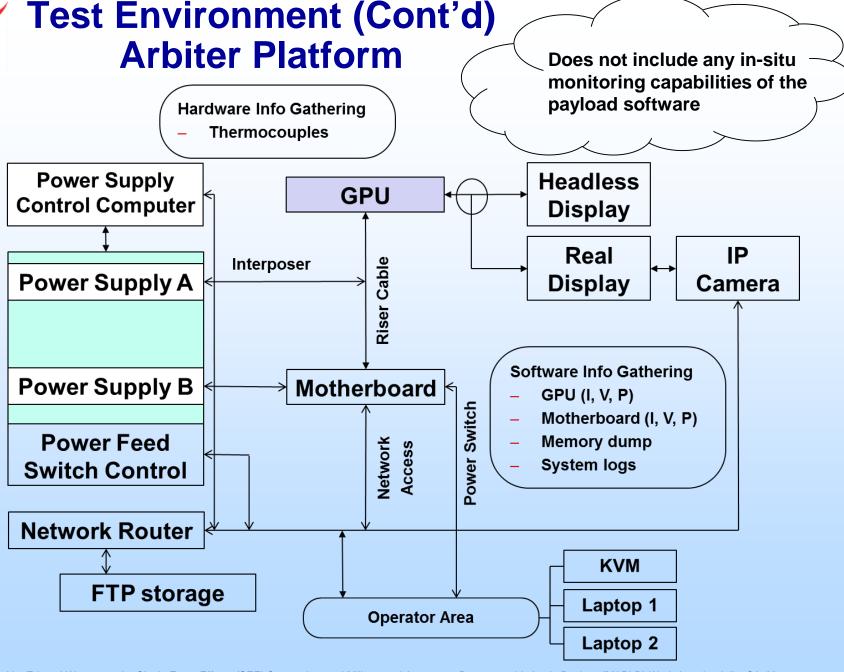
#### Beam line

- DUT testing zone where collateral damage can happen
- Shielding for everything non-DUT

#### Operator Area

- Cables, interconnects and extenders
- Signal integrity at a distance
- "Everything that was done in a lab, in front of you on a bench, now must be done from a distance..."



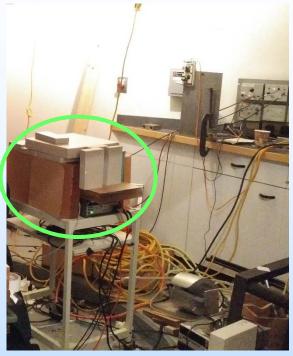




# **Test Environment (Cont'd)**









**Tripod and mounting** 

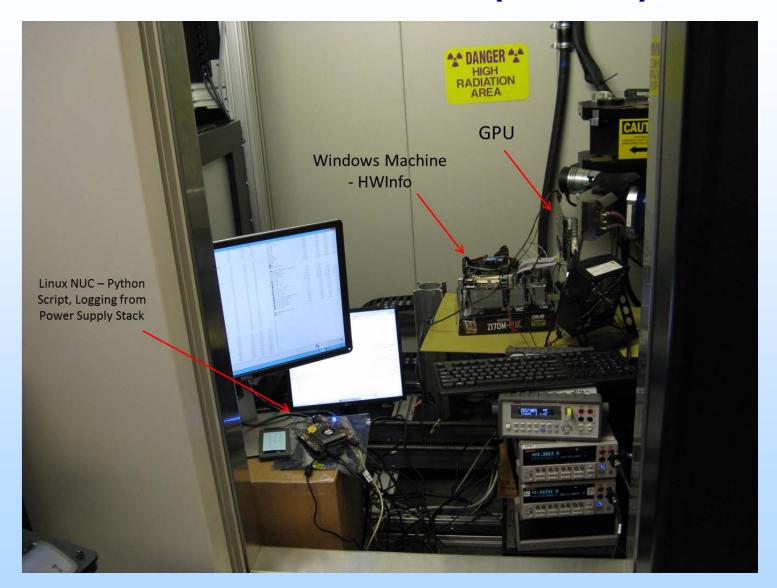
**External power** 

**Power injection** 

Arrows and circle mark locations of the lead and acrylic block fortresses



## **Test Environment (Cont'd)**





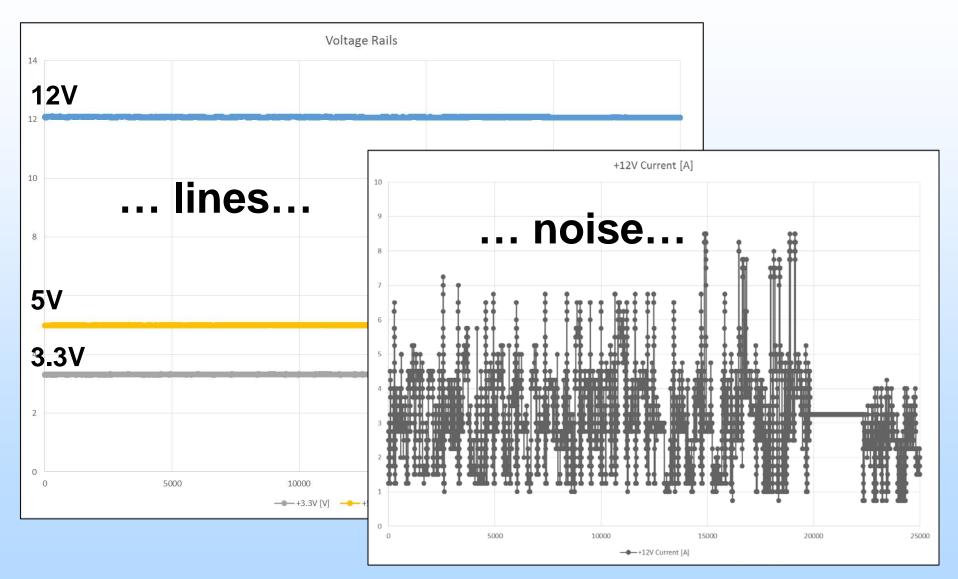
#### **DUT Health Status**

#### Accessible nodes

- Network
  - Heart beat by inbound ping
  - Heart beat by timestamp upload
- Peripherals response
  - "Num lock"
- Visual check
  - Remote
  - Local
  - Local with remote viewing
- Electrical states



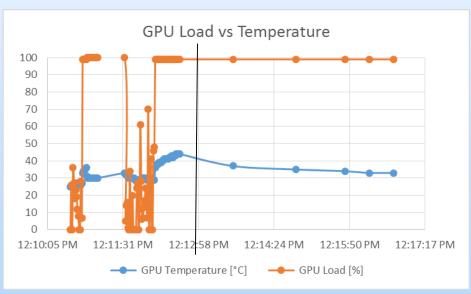
# **Monitoring Data**

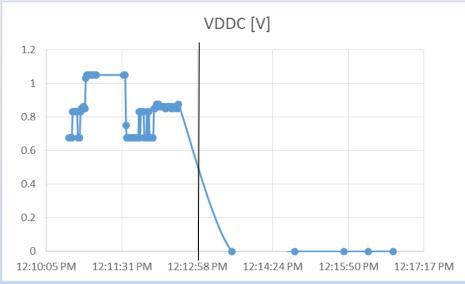




# **Monitoring Data (Cont'd)**

- Significant digits are important
- Resolution is needed for correlation
  - Faster sampling speed
  - Smaller units (µV or mV, not Volts)

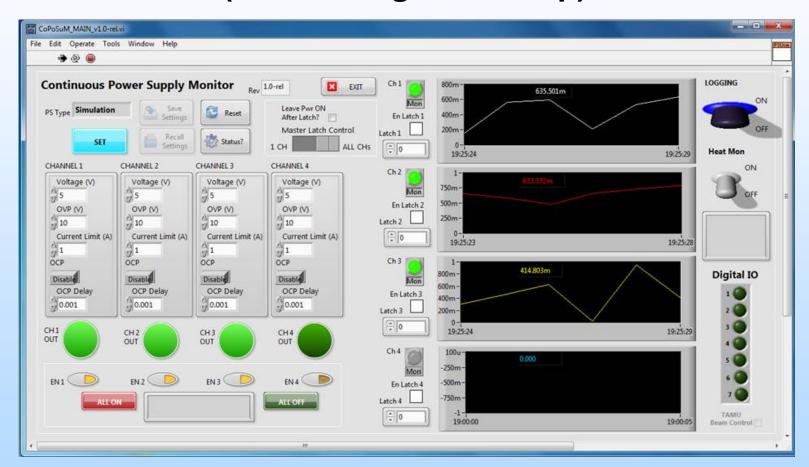






## **Monitoring Data (Cont'd)**

Even better (albeit being a mock up):





#### What does a failure look like?





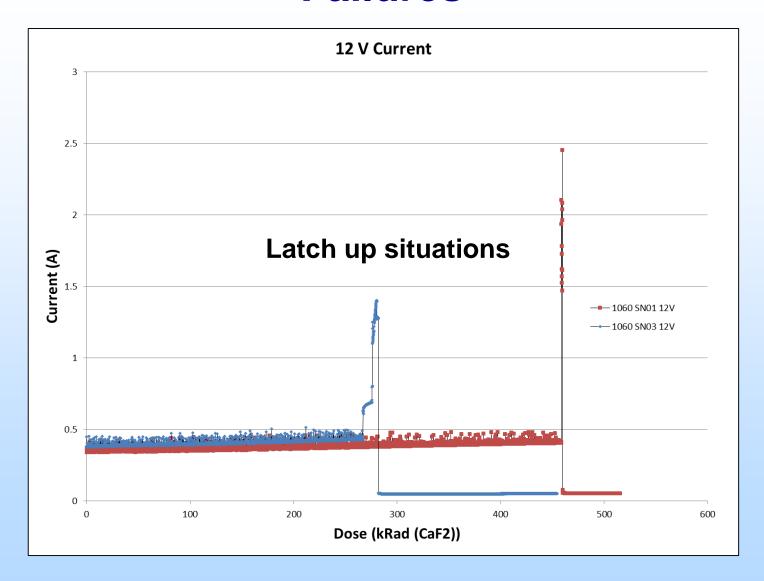
Your PC ran into a problem and needs to restart. We're just collecting some error info, and then we'll restart for you. (0% complete)

you'd like to know more, you can search online later for this error. WHEA\_UNCORRECTABLE\_ERROR





### **Failures**





## **Learning Experience**

- Every test is another learning experience
  - "Is the laser alignment jig in the beam path..."
  - Nuances with controllable nodes
    - DUT power switch
    - Remote power sources
    - DUT electrical isolation from test platform
    - Thermal paths
  - Improvements are always possible, but preparation time may not be as abundant
  - Prioritization during development is important
    - Software payload
    - Hardware monitoring
    - Remote troubleshooting capabilities



#### Conclusion

- NEPP and its partners have conducted proton, neutron and heavy ion testing on several devices
  - Have captured SEUs (SBU & MBU),
  - Have seen traceable current spikes,
  - But predominately have encountered system-based SEFIs
- GPU testing requires a complex platform to arbitrate the test vectors, monitor the DUT (in multiple ways) and record data
  - None of these should require the DUT itself to reliably perform a task outside of being exercised
- Progress has been made in proving out multiple ways to simulate and enumerate activity on the DUT
  - Narrowing down on a universal test bench
  - End goal is to make test code platform independent